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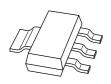
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# **PBSS8110Z**

# 100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor Rev. 02 — 8 January 2007

**Product data sheet** 

## **Product profile**

#### 1.1 General description

NPN low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor in a SOT223 (SC-73) small Surface-Mounted Device (SMD) plastic package.

PNP complement: PBSS9110Z.

#### 1.2 Features

- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High collector current gain (h<sub>FE</sub>) at high I<sub>C</sub>
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

### 1.3 Applications

- High-voltage DC-to-DC conversion
- High-voltage MOSFET gate driving
- High-voltage motor control
- High-voltage power switches (e.g. motors, fans)
- Automotive applications

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CEO}$	collector-emitter voltage	open base	-	-	100	V
I <sub>C</sub>	collector current		-	-	1	Α
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-	3	Α
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = 1 A;$ $I_B = 100 \text{ mA}$	[1] -	160	200	mΩ

[1] Pulse test:  $t_0 \le 300 \,\mu s$ ;  $\delta \le 0.02$ .



100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

## 2. Pinning information

Table 2. Pinning

Idbio L.	· ····································		
Pin	Description	Simplified outline	Symbol
1	base		
2	collector	4	2, 4
3	emitter		1 —
4	collector		' ]
		⊟1 ⊟2 ⊟3	3
			sym016

## 3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
PBSS8110Z	SC-73	plastic surface-mounted package with increased heat sink; 4 leads	SOT223		

## 4. Marking

Table 4. Marking codes

3	
Type number	Marking code
PBSS8110Z	PB8110

# 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

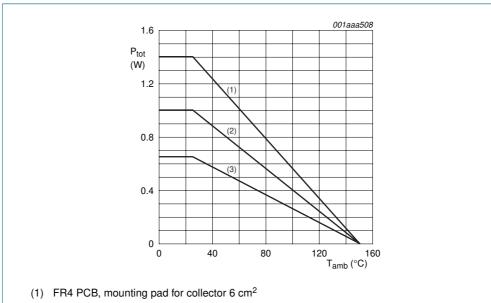
Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	120	V
$V_{CEO}$	collector-emitter voltage	open base	-	100	V
$V_{EBO}$	emitter-base voltage	open collector	-	5	V
I <sub>C</sub>	collector current		-	1	Α
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	3	Α
I <sub>B</sub>	base current		-	0.3	Α
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25  ^{\circ}C$	[1] -	0.65	W
			[2] -	1	W
			[3] _	1.4	W

#### 100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

**Table 5.** Limiting values ...continued In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$T_j$	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.



- (2) FR4 PCB, mounting pad for collector 1 cm<sup>2</sup>
- (3) FR4 PCB, standard footprint

Fig 1. Power derating curves

### 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
ιι() α)	thermal resistance from	in free air	<u>[1]</u> _	-	192	K/W
junction to ambient			[2] _	-	125	K/W
			[3] _	-	89	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	17	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.

100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

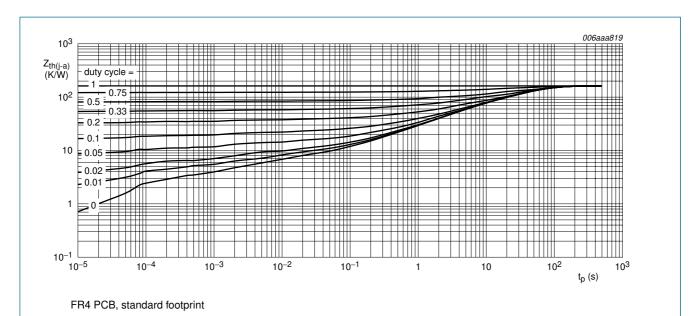


Fig 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

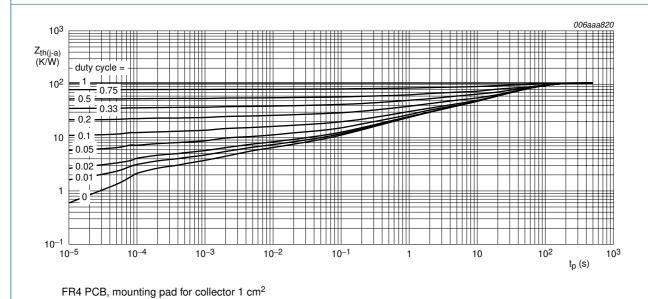
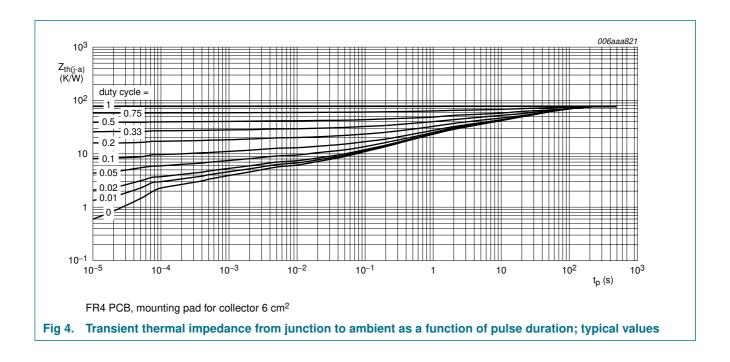


Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor



## 100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

## 7. Characteristics

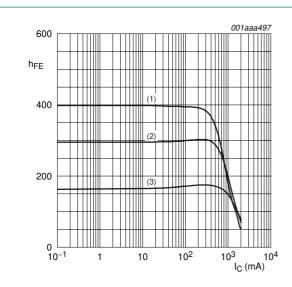
Table 7. Characteristics

T<sub>amb</sub> = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I <sub>CBO</sub>	collector-base cut-off	$V_{CB} = 80 \text{ V}; I_E = 0 \text{ A}$		-	-	100	nA
	current	$V_{CB} = 80 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 \text{ °C}$		-	-	50	μΑ
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE} = 80 \text{ V};$ $V_{BE} = 0 \text{ V}$		-	-	100	nA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 4 \text{ V}; I_C = 0 \text{ A}$		-	-	100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = 10 \text{ V};$ $I_{C} = 1 \text{ mA}$		150	-	-	
		V <sub>CE</sub> = 10 V; I <sub>C</sub> = 250 mA		150	-	500	
		$V_{CE} = 10 \text{ V};$ $I_{C} = 0.5 \text{ A}$	[1]	100	-	-	
		$V_{CE} = 10 \text{ V}; I_{C} = 1 \text{ A}$	[1]	80	-	-	
V <sub>CEsat</sub>	collector-emitter saturation voltage	$I_C = 100 \text{ mA};$ $I_B = 10 \text{ mA}$		-	-	40	mV
		$I_{C} = 500 \text{ mA};$ $I_{B} = 50 \text{ mA}$	[1]	-	-	120	mV
		I <sub>C</sub> = 1 A; I <sub>B</sub> = 100 mA	[1]	-	-	200	mV
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = 1 A;$ $I_B = 100 \text{ mA}$	[1]	-	160	200	$m\Omega$
$V_{BEsat}$	base-emitter saturation voltage	$I_C = 1 A;$ $I_B = 100 \text{ mA}$	[1]	-	-	1.05	V
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = 10 \text{ V}; I_{C} = 1 \text{ A}$	[1]	-	-	0.9	V
t <sub>d</sub>	delay time	$V_{CC} = 10 \text{ V};$		-	25	-	ns
t <sub>r</sub>	rise time	$I_C = 0.5 \text{ A};$		-	220	-	ns
t <sub>on</sub>	turn-on time	$I_{Bon} = 0.025 \text{ A};$ $I_{Boff} = -0.025 \text{ A}$		-	245	-	ns
t <sub>s</sub>	storage time	_ =		-	365	-	ns
t <sub>f</sub>	fall time			-	185	-	ns
t <sub>off</sub>	turn-off time			-	550	-	ns
f <sub>T</sub>	transition frequency	V <sub>CE</sub> = 10 V; I <sub>C</sub> = 50 mA; f = 100 MHz		100	-	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = 10 \text{ V};$ $I_E = i_e = 0 \text{ A};$ $f = 1 \text{ MHz}$		-	-	7.5	pF

<sup>[1]</sup> Pulse test:  $t_p \le 300 \ \mu s$ ;  $\delta \le 0.02$ .

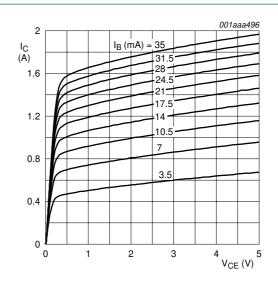
100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor



$$V_{CE} = 10 \text{ V}$$

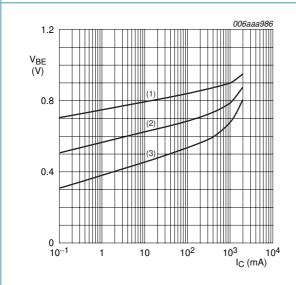
- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

Fig 5. DC current gain as a function of collector current; typical values



T<sub>amb</sub> = 25 °C

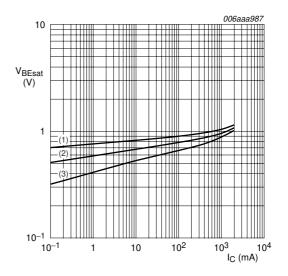
Fig 6. Collector current as a function of collector-emitter voltage; typical values





- (1)  $T_{amb} = -55 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 7. Base-emitter voltage as a function of collector current; typical values



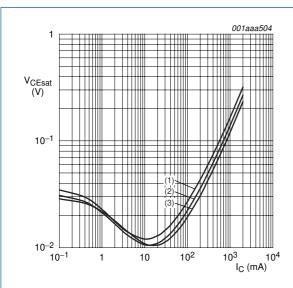
 $I_{\rm C}/I_{\rm B}=10$ 

- (1)  $T_{amb} = -55 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values

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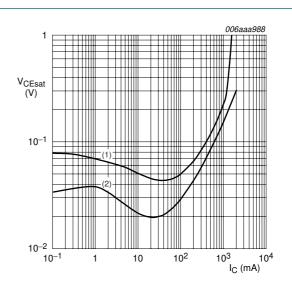
100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor



$$I_{\rm C}/I_{\rm B} = 10$$

- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

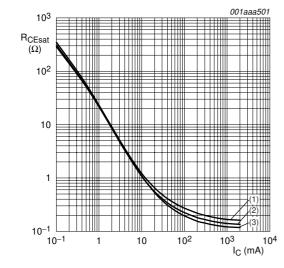
Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

- (1)  $I_C/I_B = 50$
- (2)  $I_C/I_B = 20$

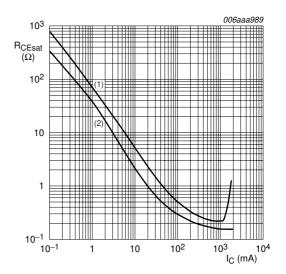
Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values





- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

- (1)  $I_C/I_B = 50$
- (2)  $I_C/I_B = 20$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

## 8. Test information

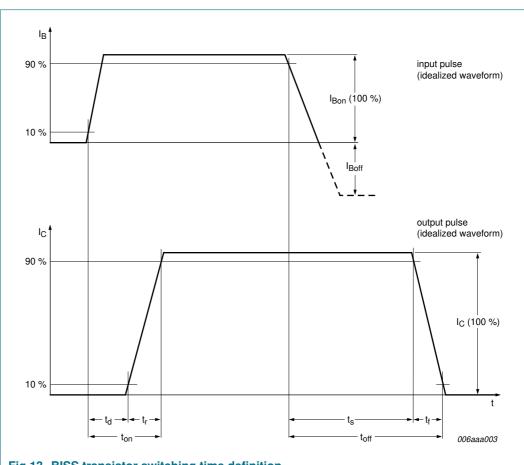
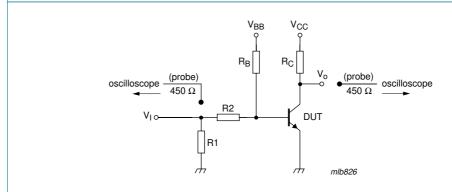


Fig 13. BISS transistor switching time definition

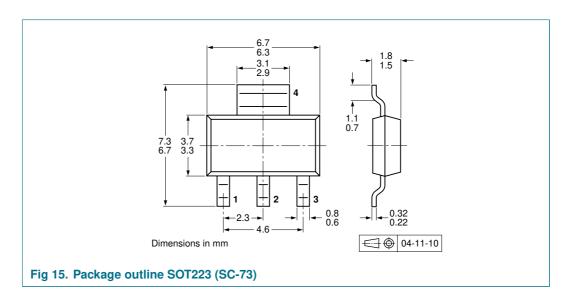


 $V_{CC}$  = 10 V;  $I_{C}$  = 0.5 A;  $I_{Bon}$  = 0.025 A;  $I_{Boff}$  = -0.025 A

Fig 14. Test circuit for switching times

100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

## 9. Package outline



# 10. Packing information

Table 8. Packing methods

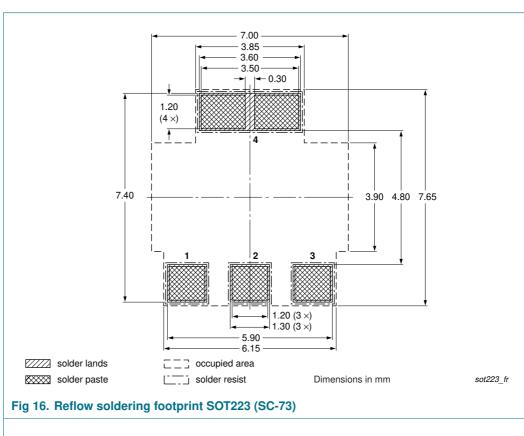
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	<b>Description</b> Packing		ing quantity	
			1000	4000	
PBSS8110Z	SOT223	8 mm pitch, 12 mm tape and reel	-115	-135	

<sup>[1]</sup> For further information and the availability of packing methods, see Section 14.

100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

## 11. Soldering



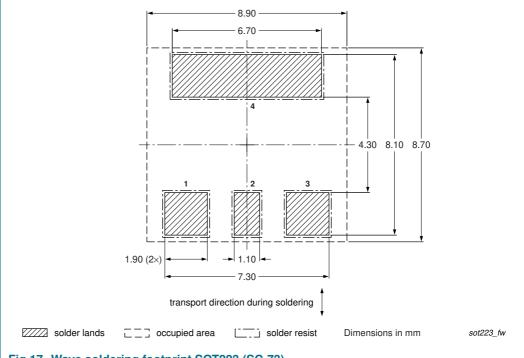


Fig 17. Wave soldering footprint SOT223 (SC-73)

## 100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

# 12. Revision history

#### Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
PBSS8110Z_2	20070108	Product data sheet	-	PBSS8110Z_1	
Modifications:	<ul> <li>The format of the NXP Semiconde</li> </ul>	iis data sheet has been redes uctors.	igned to comply with the	e new identity guidelines of	
	<ul> <li>Legal texts have</li> </ul>	e been adapted to the new co	mpany name where app	propriate.	
	<ul> <li>Section 1.1 "Ge</li> </ul>	neral description": amended			
	Section 1.2 "Feating 1.2"	atures": amended			
	<ul> <li>Section 1.3 "Ap</li> </ul>	plications": amended			
	<ul> <li>Table 1 "Quick r</li> </ul>	eference data": conditions for	$I_{\text{CM}}$ peak collector curre	ent adapted	
	• Table 1: R <sub>CEsat</sub>	equivalent on-resistance rede	fined to collector-emitte	r saturation resistance	
	<ul> <li>Table 2 "Pinning</li> </ul>	: simplified outline drawing a	mended		
		g codes": amended			
		<mark>g values"</mark> : conditions for I <sub>CM</sub> po		•	
		perating ambient temperature	redefined to ambient te	mperature	
	<u>Table 6 "Thermal characteristics"</u> : amended				
		hermal resistance from junction junction to solder point	on to soldering point red	defined to R <sub>th(j-sp)</sub> thermal	
	• Figure 2: amend	ded			
	<ul> <li>Figure 2: Z<sub>th</sub> tra junction to ambi</li> </ul>	nsient thermal impedance rec ent	lefined to $Z_{th(j-a)}$ transien	nt thermal impedance from	
	<ul> <li>Figure 2: t<sub>p</sub> puls</li> </ul>	e time redefined to pulse dura	ation		
	• Figure 3 and 4:	added			
	• Table 7: R <sub>CEsat</sub>	equivalent on-resistance rede	fined to collector-emitte	r saturation resistance	
	• Table 7: switching	ng times added			
	• <u>Figure 5, 6, 8</u> ar	nd <u>12</u> : amended			
	Section 8 "Test	information": added			
		rseded by minimized package	outline drawing		
		king information": added			
	Section 11 "Solo				
	Section 13 "Leg	al information": updated			
PBSS8110Z_1	20040426	Product data sheet	-	-	

100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

## 13. Legal information

#### 13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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## 100 V, 1 A NPN low V<sub>CEsat</sub> (BISS) transistor

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